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Table of contents

Volume 256

Scanning Probe Microscopy 2017 (SPM-2017)
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Preface

011001
OPEN ACCESS
[Scanning Probe Microscopy 2017 \(SPM-2017\)](#)

011002
OPEN ACCESS
[Peer review statement](#)

New Methods of Scanning Probe Microscopy

012001
OPEN ACCESS
[Scanning probe nanolithography of resistive memory element based on titanium oxide memristor structures](#)

V I Avilov, N V Polupanov, R V Tominov, V A Smirnov and O A Ageev.....1

012002
OPEN ACCESS
[Optomechanical coupling between AFM cantilever and semiconductor laser](#)

P A Alekseev, V A Sharov, A O Mikhaylov, M S Dunaevskii and A Baranov.....5

012003

OPEN ACCESS

[Reducing the influence of the surface roughness on the hardness measurement using instrumented indentation test](#)

I Maslenikov, A Useinov, A Birykov and V Reshetov.....10

012004

OPEN ACCESS

[Multi-frequency data analysis in AFM by wavelet transform](#)

V Pukhova and G Ferrini.....15

012005

OPEN ACCESS

[Investigation of photoconductivity of individual InAs/GaAs\(001\) quantum dots by Scanning Near-field Optical Microscopy](#)

D O Filatov, I A Kazantseva, N V Baidus', A P Gorshkov and V P Mishkin.....24

012006

OPEN ACCESS

[The generation of the electrical oscillations in a contact of an AFM probe to an individual Au nanoparticle in a SiO₂/Si film](#)

D O Filatov, O N Gorshkov, D A Antonov, M E Shenina, D Yu Sinutkin, A V Zenkevich and Yu A Matveev.....30

012007

OPEN ACCESS

[Application of focused ion beam for the fabrication of AFM probes](#)

A S Kolomiytsev, S A Lisitsyn, V A Smirnov, A A Fedotov and Yu N Varzarev.....35

012008

OPEN ACCESS

[Thermal excitation contribution into the electromechanical performance of self-supported Gd-doped ceria membranes](#)

A D Ushakov, E Mishuk, D O Alikin, B N Slautin, A A Esin, I S Baturin, V Ya Shur, I Lubomirsky and A L Kholkin.....39

Scanning Probe Microscopy in Biology and Medicine

012009

OPEN ACCESS

[The study of electrical conductivity of DNA molecules by scanning tunneling spectroscopy](#)

T I Sharipov and R Z Bakhtizin.....45

012010

OPEN ACCESS

[Peculiarities of living cell response to the external stimuli revealed via quasistatic mode of atomic force microscopy](#)

M M Khalisov, A V Ankudinov, V A Penniyaynen, T E Timoshenko, K I Timoshchuk, M V Samsonov and V P Shirinsky.....49

012011

OPEN ACCESS

[Formation features and AFM studies of the silicon-chitosan-containing glycerohydrogel surface](#)

Yu Yu Zhuravleva, O N Malinkina, D N Bratashov and A B Shipovskaya.....55

012012

OPEN ACCESS

[Local Young's moduli of as-grown and annealed diphenylalanine nanotubes](#)

P S Zelenovskiy, V V Yuzhakov, S G Vasilev, A L Kholkin and V Ya Shur.....66

012013

OPEN ACCESS

[High-speed precise cell patterning by pulsed electrohydrodynamic jet printing](#)

A V Makaev, E A Mingaliev, V R Karpov, I V Zubarev, V Ya Shur and O S El'kina.....70

012014

OPEN ACCESS

[Study of structural colour of *Hebomoia glaucippe* butterfly wing scales](#)

V Ya Shur, D K Kuznetsov, V I Pryakhina, M S Kosobokov, I V Zubarev, S K Boymuradova and K V Volchetskaya.....76

012015

OPEN ACCESS

[Combination of atomic force microscopy and mass spectrometry for the detection of target protein in the serum samples of children with autism spectrum disorders](#)

A L Kaysheva, T O Pleshakova, A T Kopylov, I D Shumov, I Y Iourov, S G Vorsanova, Y B Yurov, V S Ziborov, A I Archakov and Y D Ivanov.....80

012016

OPEN ACCESS

[Physical-mechanical image of the cell surface on the base of AFM data in contact mode](#)

M N Starodubtseva, I E Starodubtsev, N I Yegorenkov, N S Kuzhel, E E Konstantinova and S A Chizhik.....83

Scanning Probe Microscopy in Materials Science

012017

OPEN ACCESS

[AFM study of the supramolecular transformation of polyaniline and polyaniline/carbon nanotubes composite upon doping with dodecylbenzenesulfonic acid in the presence of a solvent](#)

I A Lobov, N A Davletkildeev and D V Sokolov.....88

012018

OPEN ACCESS

[Combination of scanning probe microscopy techniques for evaluating the electrical parameters of individual multiwalled carbon nanotubes](#)

D V Sokolov, N A Davletkildeev, V V Bolotov and I A Lobov.....94

012019

OPEN ACCESS

[Scanning probe microscopy in mineralogical studies: about origin of the observed roughness of natural silica-rich glasses](#)

Ye A Golubev and S I Isaenko.....98

012020

OPEN ACCESS

[Phase transitions in copper oxide thin films under proton irradiation](#)

M M Dementyeva, K E Prikhodko, B A Gurovich, Z V Bukina, D A Komarov and L V Kutuzov.....105

012021

OPEN ACCESS

[Study of the field emission graphene/SiC nanostructures using scanning probe microscopy](#)

I L Jityaev, A M Svetlichnyi, A S Kolomiitsev, E Yu Volkov, V V Polyakova and O A Ageev.....110

SPM Analytical Methods and Probe Lithography

012022

OPEN ACCESS

[Tribological properties investigation of the thermoplastic elastomers surface with the AFM lateral forces mode](#)

T A Kuznetsova, T I Zubar, V A Lapitskaya, K A Sudzilouskaya, S A Chizhik, A L Didenko, V M Svetlichnyi, M E Vylegzhanina, V V Kudryavtsev and T E Sukhanova.....114

012023

OPEN ACCESS

[Profiling of nanostructures by scratching probe nanolithography and plasma chemical etching](#)

R V Tominov, V V Bespoludin, V S Klimin, V A Smirnov and O A Ageev.....120

012024

OPEN ACCESS

[Piezoelectric effect in non-uniform strained carbon nanotubes](#)

M V Ilina, Yu F Blinov, O I Ilin, N N Rudyk and O A Ageev.....124

Ferroics

012025

OPEN ACCESS

[In situ visualization of domain structure evolution during field cooling in 0.67PMN-0.33PT single crystal](#)

A D Ushakov, A A Esin, D S Chezganov, A P Turygin, A R Akhmatkhanov, Q Hu, L Sun, X Wei and V Ya Shur.....128

012026

OPEN ACCESS

[Model for growth of fractal solid state surface and possibility of its verification by means of atomic force microscopy](#)

D A Kulikov, A A Potapov, A E Rassadin and A V Stepanov.....133

012027

OPEN ACCESS

[The phase-field modeling of the self-organized phase growth with three-fold symmetry](#)

A R Akhmatkhanov, A I Lobov, M A Chuvakova, E D Saveliev and V Ya Shur.....142